® **contact our Technical Support Center at**

NO RECOMMENDED REPLACEMENT Center

contact our Technical Support Support

contact Our Technical Support Support

HI5721

Data Sheeting WWW. Illie **Charles March 2003**

FN3949.8

10-Bit, 125MSPS, High Speed D/A Converter

The HI5721 is a 10-bit, 125MSPS, high speed D/A converter. The converter incorporates a 10-bit, input data register with quadrature data logic capability and current outputs. The HI5721 features low glitch energy and excellent frequency domain specifications.

**OBSOLETE PRODUCT

OBSOLETE DREPLACEMENT**

NO RECOMMENDED Support Center

OBSOLENDED Cupport Centricom/tsc
NO RECOMMENDical Support Centricom/tsc
contact our Technical Support Centricom/tsc
1-888-INTERSIL or www.intersil.com/tsc

Part Number Information

Features

• Improved Second Source for the AD9721

Applications

- Wireless Communications
- Direct Digital Frequency Synthesis
- Signal Reconstruction
- HDTV
- Test Equipment
- High Resolution Imaging Systems
- Arbitrary Waveform Generators

Pinout

Typical Applications Circuit

Functional Block Diagram

Absolute Maximum Ratings Thermal Information

Operating Conditions

Temperature Range. -40oC to 85oC

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. θ_{JA} is measured with the component mounted on an evaluation PC board in free air.

Electrical Specifications AV_{EE} , $DVEE = -4.94$ to $-5.46V$, $V_{CC} = +4.75$ to $+5.25V$, CTRL AMP IN = REF OUT, $T_A = 25^{\circ}C$ for All Typical Values

Electrical Specifications $AVEE$, $DVEE = -4.94$ to $-5.46V$, $V_{CC} = +4.75$ to $+5.25V$, CTRL AMP IN = REF OUT, $T_A = 25^{\circ}$ C for All Typical Values **(Continued)**

Electrical Specifications $AVEE$, $DVEE = -4.94$ to $-5.46V$, $V_{CC} = +4.75$ to $+5.25V$, CTRL AMP IN = REF OUT, $T_A = 25^{\circ}$ C for All Typical Values **(Continued)**

NOTES:

2. Gain Error measured as the error in the ratio between the full scale output current and the current through RSET (typically 640µA). Ideally the ratio should be 32.

3. Parameter guaranteed by design or characterization and not production tested.

4. All devices are 100% tested at 25°C. 100% productions tested at temperature extremes for military temperature devices, sample tested for industrial temperature devices.

5. Spectral measurements made without external filtering.

5

Timing Diagrams

FIGURE 1. FULL SCALE SETTLING TIME DIAGRAM FIGURE 2. PEAK GLITCH AREA (SINGLET) MEASUREMENT METHOD

FIGURE 3. PROPAGATION DELAY, SETUP TIME, HOLD TIME AND MINIMUM PULSE WIDTH DIAGRAM

Typical Performance Curves

FIGURE 6. SPURIOUS FREE DYNAMIC RANGE TO NYQUIST 25MHz FUNDAMENTAL

FIGURE 5. DIFFERENTIAL NON-LINEARITY

FIGURE 7. SPURIOUS FREE DYNAMIC RANGE TO NYQUIST 2MHz FUNDAMENTAL

<u>intersil</u> 7

FIGURE 12. SIGNAL TO NOISE + DISTORTION vs OUTPUT FREQUENCY

FIGURE 11. SIGNAL TO NOISE RATIO vs OUTPUT FREQUENCY

FIGURE 13. TOTAL HARMONIC DISTORTION vs OUTPUT FREQUENCY

FIGURE 14. GAIN ERROR vs TEMPERATURE FIGURE 15. OFFSET ERROR vs TEMPERATURE

Typical Performance Curves (Continued)

FIGURE 16. REFERENCE VOLTAGE vs TEMPERATURE

NOTE: Clock Frequency does not alter power dissipation. **FIGURE 17. POWER DISSIPATION vs TEMPERATURE**

9

Detailed Description

The HI5721 is a 10-bit, current out D/A converter. The DAC can convert at 125 MSPS and runs on +5V and -5.2V supplies. The architecture is an R/2R and segmented switching current cell arrangement to reduce glitch and maintain 10-bit linearity without laser trimming. The HI5721 achieves its low power and high speed performance from an advanced BiCMOS process. The HI5721 consumes 700mW (typical) and has an improved hold time of only 0.5ns (typical). The HI5721 is an excellent converter to be used for communications applications and high performance video systems.

Digital Inputs

The HI5721 is a TTL/CMOS compatible D/A. The inputs can be inverted using the INVERT pin. When INVERT is LOW ('0') the input quadrature logic simply passes the data through unchanged.

When INVERT is HIGH ('1') bits D0 (LSB) through D8 are inverted. D9 is not inverted and can be considered a sign bit when enabling this quadrature compatible mode. The INVERT function can simplify the requirements for large sine wave lookup tables in a Numerically Controlled Oscillator. The NCO used in a DDS application would only have to store or generate 90 degrees of information and then use the INVERT control to control the sign of the output waveform.

Data Buffer/Level Shifters

Data inputs D0 (LSB) through D9 (MSB) are internally translated from TTL to ECL. The internal latch and switching current source controls are implemented in ECL technology to maintain high switching speeds and low noise characteristics.

Decoder/Driver

The architecture employs a split R/2R and Segmented Current source arrangement. Bits D0 (LSB) through D5 directly drive a typical R/2R network to create the binary weighted current sources. Bits D6 through D9 (MSB) pass through a "thermometer" encoder that converters the incoming data into 15 individual segmented current source enables. The split architecture helps to improve glitch while maintaining 10-bit linearity without laser trimming. The worst case glitch is more constant across the entire output transfer function.

Clocks and Termination

The internal 10-bit register is updated on the rising edge of the clock. Since the HI5721 clock rate can run to 125 MSPS, to minimize reflections and clock noise into the part proper termination should be used. In PCB layout clock runs should be kept short and have a minimum of loads. To guarantee consistent results from board to board, controlled impedance PCBs should be used with a characteristic line impedance Z_{O} of 50Ω .

To terminate the clock line a shunt terminator to ground is the most effective type at a 125 MSPS clock rate. A typical value for termination can be determined by the equation:

 $R_T = Z_O$,

for the termination resistor. For a controlled impedance board with a Z_{O} of 50 Ω , the R_T = 50 Ω . Shunt termination is best used at the receiving end of the transmission line or as close to the HI5721 CLK pin as possible.

FIGURE 18. AC TERMINATION OF THE HI5721 CLOCK LINE

Rise and Fall times and propagation delay of the line will be affected by the Shunt Terminator. The terminator can be connected to DGND.

Noise Reduction

To reduce power supply noise, separate analog and digital power supplies should be used with 0.1μ F and 0.01μ F ceramic capacitors placed as close to the body of the HI5721 as possible on the analog (AV_{FF}) and digital (DV_{FF}) supplies. The analog and digital ground returns should be connected together back at the device to ensure proper operation on power up. The V_{CC} power pin should be decoupled with a 0.1µF capacitor.

Reference

The internal reference in the HI5721 is a -1.25V (typical) bandgap voltage reference with a 100μ V/^oC temperature drift (typical). The internal reference should be buffered by the Control Amplifier to provide adequate drive for the segmented current cells and the R/2R resistor ladder. Reference Out (REF OUT) should be connected to the Control Amplifier Input (CTRL AMP IN). The Control Amplifier Output (CTRL AMP OUT) should be used to drive the Reference Input (REF IN) and a 0.1μ F capacitor to analog V- (AV_{EE}). This improves settling time by decoupling switching noise from the analog output of the HI5721.

The Full Scale Output Current is controlled by the CTRL AMP IN pin and the set resistor (R_{SFT}) . The ratio is:

 I_{OUT} (Full Scale) = (V_{CTRL} AMP IN $/$ R_{SET}) x 32.

Multiplying Capability

The HI5721 can operate in two different multiplying configurations. First, using the CTRL AMP IN input pin, a -0.6V to -1.2V signal can be applied with a bandwidth up to 1MHz. To increase the multiplying bandwidth, the 0.1μ F capacitor connected from REF IN to AV_{EE} can be reduced.

FIGURE 19. LOW FREQUENCY MULTIPLYING CIRCUIT

If higher multiplying frequencies are desired, the reference input can be directly driven. The analog signal range is -3.3V to -4.25V. The multiplying signal must be capacitively coupled into REF IN onto a DC bias between -3.3V to -4.25V (-3.8V typically).

FIGURE 20. WIDEBAND MULTIPLYING CIRCUIT

Outputs

The outputs I_{OUT} and $I_{\overline{\text{OUT}}}$ are complementary current outputs. Current is steered to either I_{OUT} or $I_{\overline{\text{OUT}}}$ in proportion to the digital input code. The sum of the two currents is always equal to the full scale current minus one LSB. The current output can be converted to a voltage by using a load resistor. Both current outputs should have the same load resistor (64Ω typically). By using a 64Ω load on the output, a 50 Ω effective output resistance (ROUT) is achieved due to the 227 Ω (\pm 15%) parallel resistance seen looking back into the output. This is the nominal value of the R2R ladder of the DAC. The 50 Ω output is needed for matching the output with a 50Ω line. The load resistor should be chosen so that the effective output resistance (R_{OUT}) matches the line resistance. The output voltage is:

$V_{\text{OUT}} = I_{\text{OUT}} \times R_{\text{OUT}}$.

 I_{OUT} is defined in the reference section. The compliance range of the output is from -1.5V to 3V, with a $1V_{P-P}$ voltage swing allowed within this range. However, if it is desired that the output be offset above zero volts, it is necessary that pin 19 (ARTN) be connected to the same voltage as the load resistor, not to exceed 3V.

Glitch

TABLE 1. INPUT CODING vs CURRENT OUTPUT

INPUT CODE (D9-D0)	I_{OUT} (mA)	$I_{\overline{OUT}}$ (mA)
11 1111 1111	-20.48	
10 0000 0000	-10.24	-10.24
00 0000 0000		-20.48

The output glitch of the HI5721 is measured by summing the area under the switching transients after an update of the DAC. Glitch is caused by the time skew between bits of the incoming digital data. Typically the switching time of digital inputs are asymmetrical meaning that the turn off time is faster than the turn on time (TTL designs). Unequal delay paths through the device can also cause one current source to change before another. To minimize this the Intersil HI5721 employes an internal register, just prior to the current sources, that is updated on the clock edge. Lastly the worst case glitch usually happens at the major transition i.e., 01 1111 1111 to 10 0000 0000. But in the HI5721 the glitch is moved to the 00 0001 1111 to 11 1110 0000 transition. This is achieved by the split R/2R segmented current source architecture. This decreases the amount of current switching at any one time and makes the glitch practically constant over the entire output range. By making the glitch a constant size over the entire output range this effectively integrates this error out of the end application.

In measuring the output glitch of the HI5721 the output is terminated into a 64 Ω load. The glitch is measured at the major carrys throughout the DAC's output range.

The glitch energy is calculated by measuring the area under the voltage-time curve. Figure 21 shows the area considered as glitch when changing the DAC output. Units are typically specified in picoVolt • seconds (pV • s).

FIGURE 21. GLITCH TEST CIRCUIT

FIGURE 22. GLITCH ENERGY

Applications

Voltage Conversion of the Output

To convert the output current of the D/A converter to a voltage, an amplifier should be used as shown in Figure 23 below. The DAC needs a 50Ω termination resistor on the I_{OUT} pin to ensure proper settling. The HFA1110 has an internal feedback resistor to compensate for high frequency operation.

FIGURE 23. HIGH SPEED CURRENT TO VOLTAGE CONVERSION

Bipolar Applications

To convert the output to a bipolar ±2.0V output swing the following applications circuit is recommended. The Reference can only provide 100µA of drive, so it must be buffered to create the bipolar offset current needed to generate -2.0V output with all bits 'off'. The output current must be converted to a voltage and then gained up and offset to produce the proper swing. Care must be taken to compensate for the output voltage swing and error.

Interfacing to the HSP45106 NCO-16

The HSP45106 is a 16-bit output, Numerically-Controlled Oscillator (NCO). The HSP45106 can be used to generate various modulation schemes for Direct Digital Synthesis (DDS) applications. Figure 25 shows how to interface an HI5721 to the HSP45106.

Interfacing to the HSP45102 NCO-12

The HSP45102 is a 12-bit output Numerically Controlled Oscillator (NCO). The HSP45102 can be used to generate various modulation schemes for Direct Digital Synthesis

12

FIGURE 24. BIPOLAR OUTPUT CONFIGURATION

(DDS) applications. Figure 26 shows how to interface an HI5721 to the HSP45102.

This high level block diagram is that of a basic PSK modulator. In this example the encoder generates the PSK waveform by driving the Phase Modulation Inputs (P1, P0) of the HSP45102. The P1-0 inputs impart a phase shift to the carrier wave as defined in Table 2.

TABLE 2. PHASE MODULATION INPUT CODING

P ₁	P ₀	PHASE SHIFT (DEGREES)
		90
		270
		180

The 10 MSBs of the HSP45102 drive the 10-bit HI5721 DAC which converts the NCO output into an analog waveform. The output filter connected to the DAC can be tailored to remove unwanted spurs for the desired carrier frequency. The controller is used to load the desired center frequency and control the HSP45102. The HI5721 coupled with the HSP45102 make an inexpensive PSK modulator with Spurious Free operation down to -76dBc.

FIGURE 25. PSK MODULATOR USING THE HI5721 AND THE HSP45106 12-BIT NCO

Definition of Specifications

Integral Linearity Error, INL, is the measure of the worst case point that deviates from a best fit straight line of data values along the transfer curve.

Differential Linearity Error, DNL, is the measure of the step size output deviation from code to code. Ideally the step size should be 1 LSB. A DNL specification of 1 LSB or less guarantees monotonicity.

Feedthru is the measure of the undesirable switching noise coupled to the output.

Output Voltage Full Scale Settling Time, is the time required from the 50% point on the clock input for a full scale step to settle within an $1/2$ LSB error band.

Output Voltage Small Scale Settling Time, is the time required from the 50% point on the clock input for a 100mV step to settle within an $\frac{1}{2}$ LSB error band. This is used by applications reconstructing highly correlated signals such as sine waves with more than 5 points per cycle.

Glitch Area, GE, is the switching transient appearing on the output during a code transition. It is measured as the area under the curve and expressed as a Volt-Time specification.

Differential Gain, ∆**AV**, is the gain error from an ideal sine wave with a normalized amplitude.

Differential Phase, ∆Φ, is the phase error from and ideal sine wave.

FIGURE 26. PSK MODULATOR USING THE HI5721 AND THE HSP45102 12-BIT NCO

Signal to Noise Ratio, SNR, is the ratio of a fundamental to the noise floor of the analog output. The first 5 harmonics are ignored, and an output filter of $1/2$ the clock frequency is used to eliminate alias products.

Total Harmonic Distortion, THD, is the ratio of the DAC output fundamental to the RMS sum of the harmonics. The first 5 harmonics are included, and an output filter of $1/2$ the clock frequency is used to eliminate alias products.

Spurious Free Dynamic Range, SFDR, is the amplitude difference from a fundamental to the largest harmonically or non-harmonically related spur. A sine wave is loaded into the D/A and the output filtered at $1/2$ the clock frequency to eliminate noise from clocking alias terms.

Intermodulation Distortion, IMD is the measure of the sum and difference products produced when a two tone input is driven into the D/A. The distortion products created will arise at sum and difference frequencies of the two tones. IMD is

 $IMD = \frac{20 \log (RMS \text{ of sum and difference distortion products})}{20 \log (RMS \text{ of sum and difference distortion products})}$ (RMS amplitude of the fundamental)

All Intersil U.S. products are manufactured, assembled and tested utilizing ISO9000 quality systems. Intersil Corporation's quality certifications can be viewed at www.intersil.com/design/quality

Intersil products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design, software and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see www.intersil.com